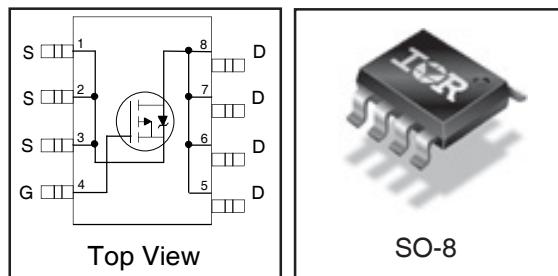


V_{DS}	-150	V
R_{DS(on)} max (@V _{GS} = -10V)	2.4	Ω
Q_g (typical)	6	nC
I_D (@T _A = 25°C)	-0.7	A



Features

Industry-standard pinout SO-8 Package
Compatible with Existing Surface Mount Techniques
RoHS Compliant, Halogen-Free
MSL1, Industrial qualification

Benefits

Multi-Vendor Compatibility
Easier Manufacturing
Environmentally Friendlier
Increased Reliability

Base Part Number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
IRF6217PbF-1	SO-8	Tube/Bulk	95	IRF6217PbF-1
		Tape and Reel	4000	IRF6217TRPbF-1

Absolute Maximum Ratings

	Parameter	Max.	Units
I _D @ T _A = 25°C	Continuous Drain Current, V _{GS} @ 10V	-0.7	
I _D @ T _A = 70°C	Continuous Drain Current, V _{GS} @ 10V	-0.5	
I _{DM}	Pulsed Drain Current ①	-5.0	
P _D @ T _A = 25°C	Power Dissipation④	2.5	W
	Linear Derating Factor	0.02	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
dv/dt	Peak Diode Recovery dv/dt	4.5	V/ns
T _J	Operating Junction and		
T _{STG}	Storage Temperature Range	-55 to + 150	°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	

Thermal Resistance

Symbol	Parameter	Typ.	Max.	Units
R _{θJL}	Junction-to-Drain Lead	—	20	
R _{θJA}	Junction-to-Ambient ④	—	50	°C/W

Notes ① through ④ are on page 8

Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	-150	—	—	V	$V_{\text{GS}} = 0\text{V}, I_D = -250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	-0.17	—	$\text{V}/^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = -1\text{mA}$ ③
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	—	2.4	Ω	$V_{\text{GS}} = -10\text{V}, I_D = -0.42\text{A}$ ③
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	-3.0	—	-5.0	V	$V_{\text{DS}} = V_{\text{GS}}, I_D = -250\mu\text{A}$
I_{DSS}	Drain-to-Source Leakage Current	—	—	-25	μA	$V_{\text{DS}} = -150\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 25^\circ\text{C}$
		—	—	-250		$V_{\text{DS}} = -120\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	-100	nA	$V_{\text{GS}} = -20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	100		$V_{\text{GS}} = 20\text{V}$

Dynamic @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

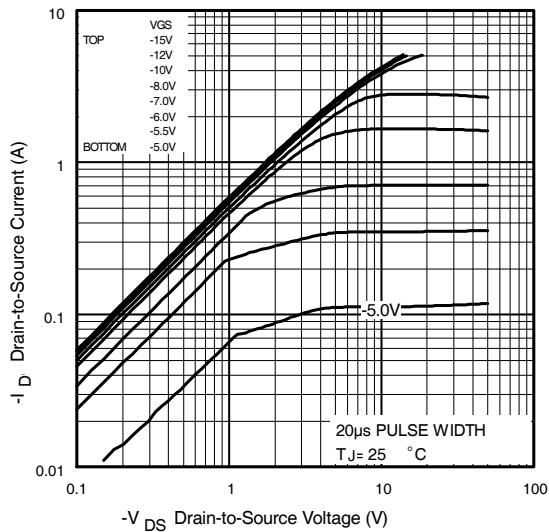
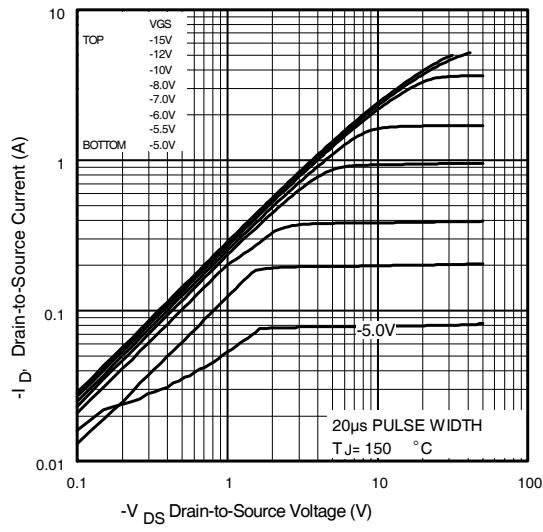
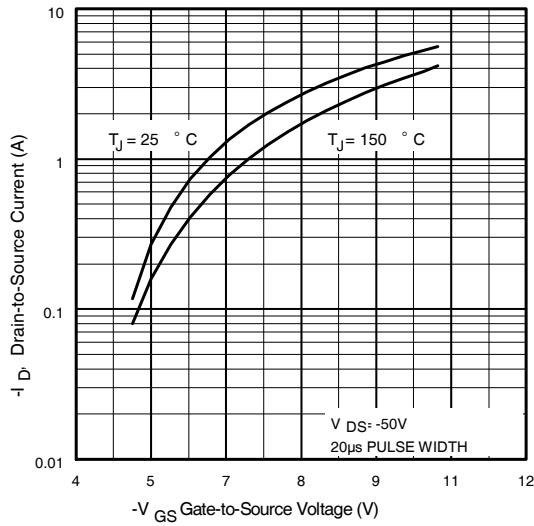
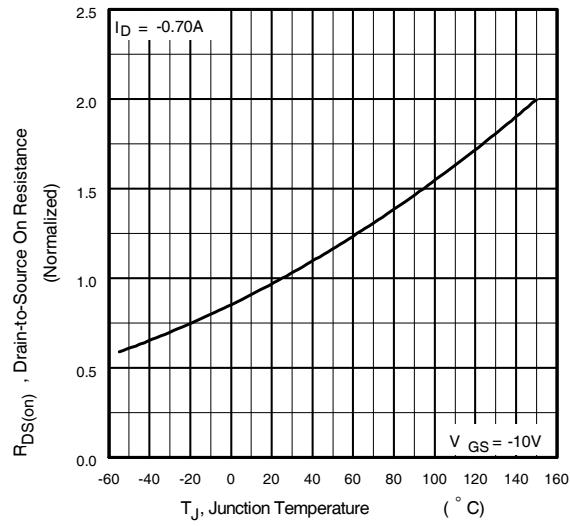
	Parameter	Min.	Typ.	Max.	Units	Conditions
g_{fs}	Forward Transconductance	0.55	—	—	S	$V_{\text{DS}} = -50\text{V}, I_D = -0.42\text{A}$
Q_g	Total Gate Charge	—	6.0	9.0	nC	$I_D = -0.42\text{A}$
Q_{gs}	Gate-to-Source Charge	—	1.6	2.4		$V_{\text{DS}} = -120\text{V}$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	2.8	4.2	ns	$V_{\text{GS}} = -10\text{V},$
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	12	—		$V_{\text{DD}} = -75\text{V}$
t_r	Rise Time	—	7.2	—		$I_D = -0.42\text{A}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	14	—		$R_G = 6.2\Omega$
t_f	Fall Time	—	16	—	pF	$V_{\text{GS}} = -10\text{V}$ ③
C_{iss}	Input Capacitance	—	150	—		$V_{\text{GS}} = 0\text{V}$
C_{oss}	Output Capacitance	—	30	—		$V_{\text{DS}} = -25\text{V}$
C_{rss}	Reverse Transfer Capacitance	—	10	—		$f = 1.0\text{KHz}$
C_{oss}	Output Capacitance	—	150	—		$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = -1.0\text{V}, f = 1.0\text{KHz}$
C_{oss}	Output Capacitance	—	15	—		$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = -120\text{V}, f = 1.0\text{KHz}$
$C_{\text{oss eff.}}$	Effective Output Capacitance	—	45	—		$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 0\text{V to } -120\text{V}$

Avalanche Characteristics

	Parameter	Typ.	Max.	Units
E_{AS}	Single Pulse Avalanche Energy②	—	15	mJ
I_{AR}	Avalanche Current①	—	-1.4	A

Diode Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_s	Continuous Source Current (Body Diode)	—	—	-1.8	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ①	—	—	-5.0		
V_{SD}	Diode Forward Voltage	—	—	-1.6	V	$T_J = 25^\circ\text{C}, I_S = -0.42\text{A}, V_{\text{GS}} = 0\text{V}$ ③
t_{rr}	Reverse Recovery Time	—	51	77	ns	$T_J = 25^\circ\text{C}, I_F = -0.42\text{A}$
Q_{rr}	Reverse Recovery Charge	—	86	130	nC	$dI/dt = -100\text{A}/\mu\text{s}$ ③

**Fig 1.** Typical Output Characteristics**Fig 2.** Typical Output Characteristics**Fig 3.** Typical Transfer Characteristics**Fig 4.** Normalized On-Resistance Vs. Temperature

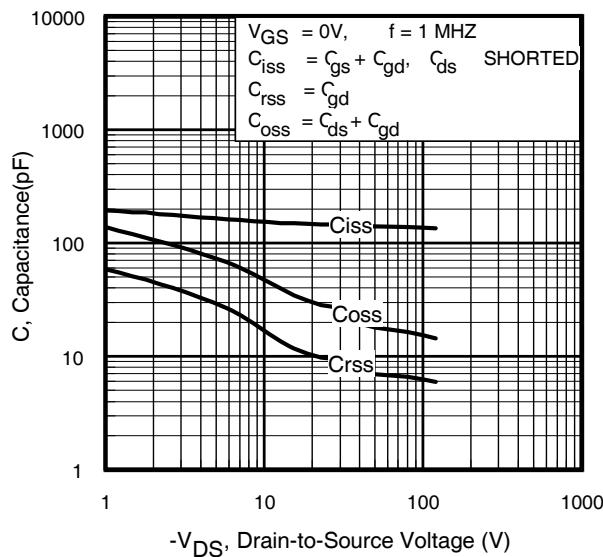


Fig 5. Typical Capacitance Vs.
Drain-to-Source Voltage

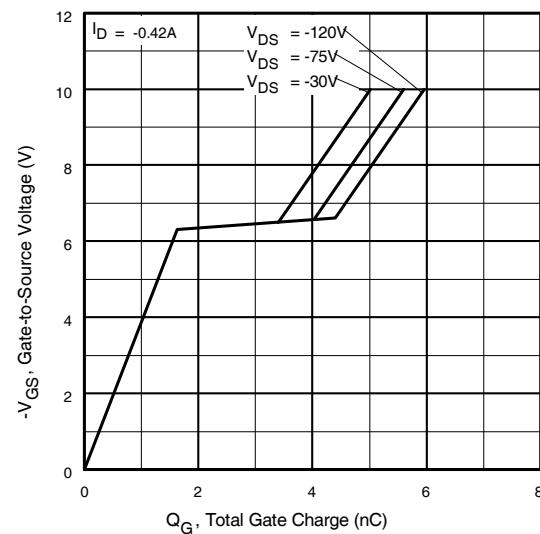


Fig 6. Typical Gate Charge Vs.
Gate-to-Source Voltage

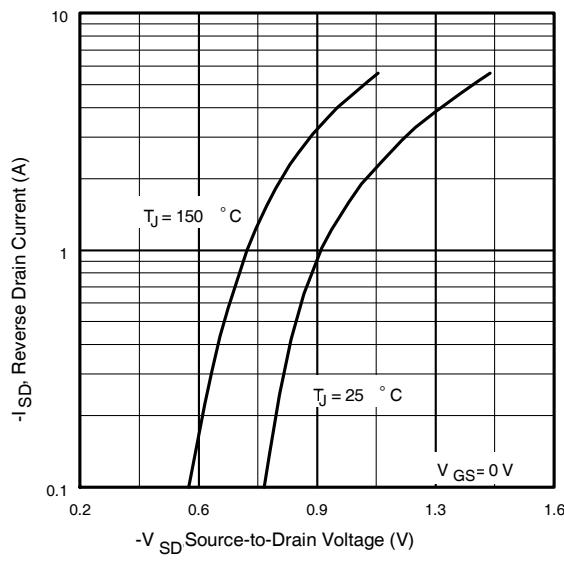


Fig 7. Typical Source-Drain Diode
Forward Voltage

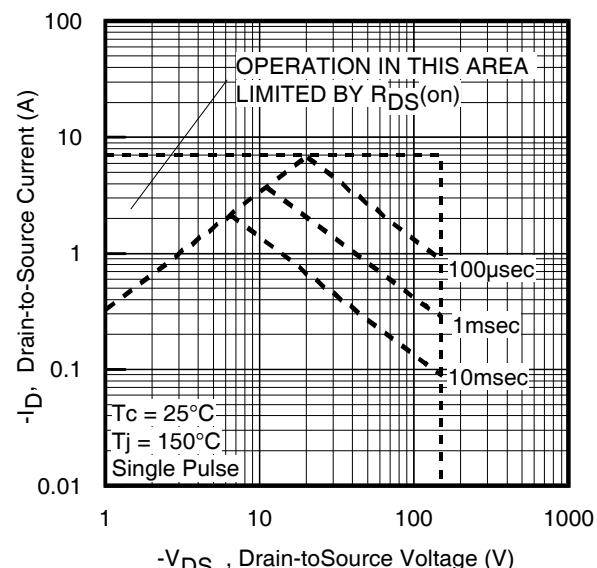


Fig 8. Maximum Safe Operating Area

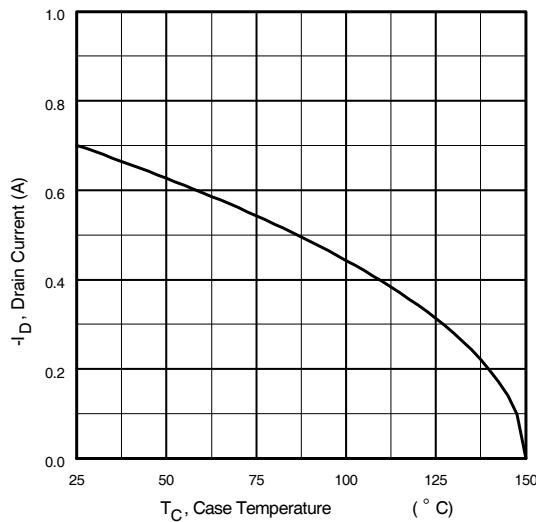


Fig 9. Maximum Drain Current Vs.
Ambient Temperature

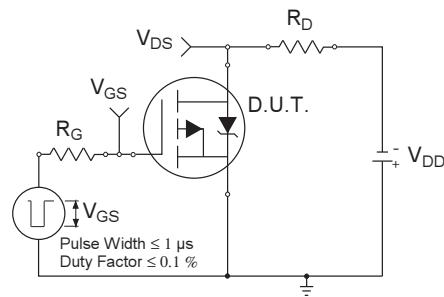


Fig 10a. Switching Time Test Circuit

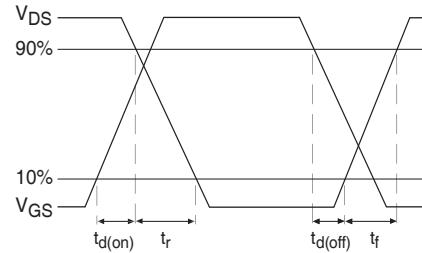


Fig 10b. Switching Time Waveforms

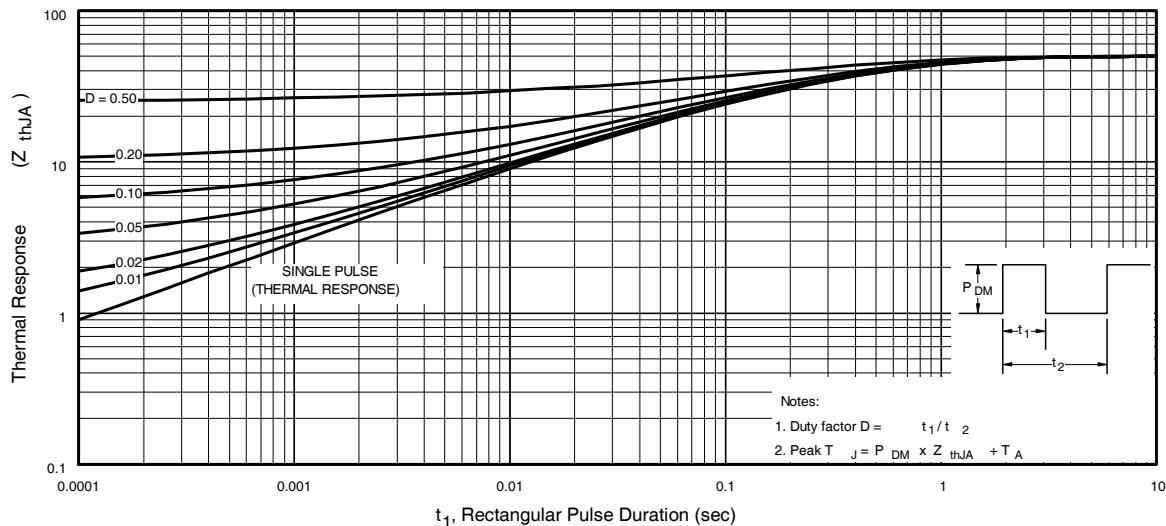


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

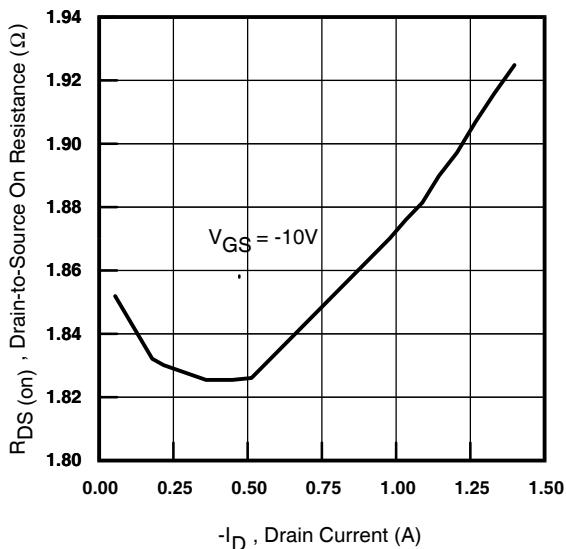


Fig 12. On-Resistance Vs. Drain Current

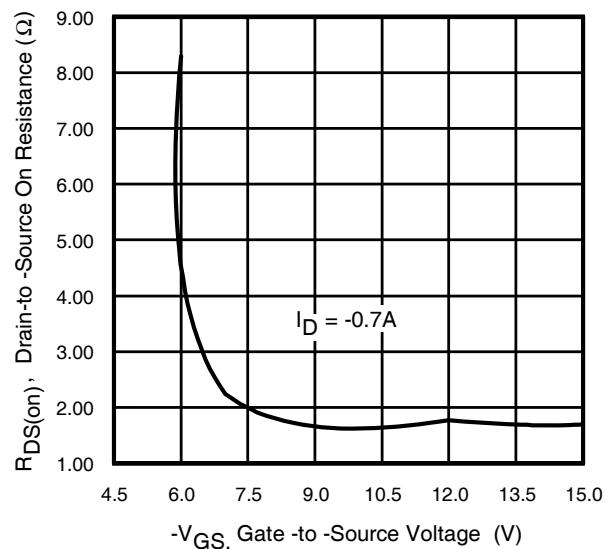


Fig 13. On-Resistance Vs. Gate Voltage

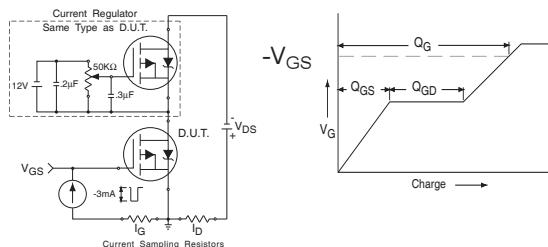


Fig 14a&b. Basic Gate Charge Test Circuit and Waveform

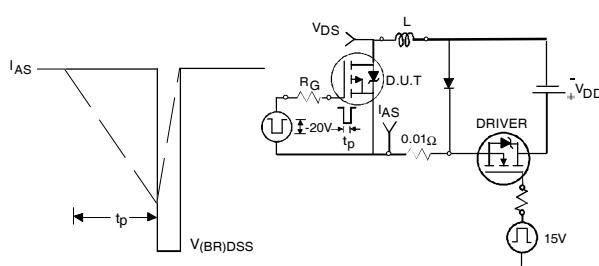


Fig 15a&b. Unclamped Inductive Test circuit and Waveforms

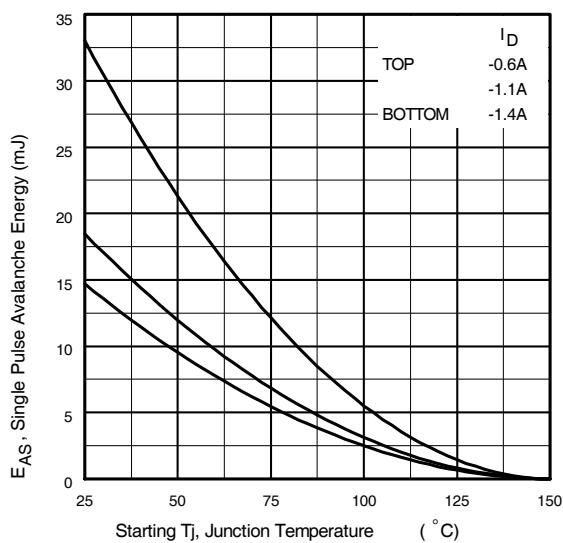
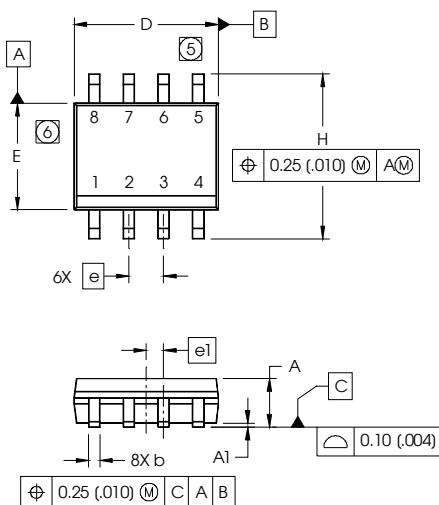


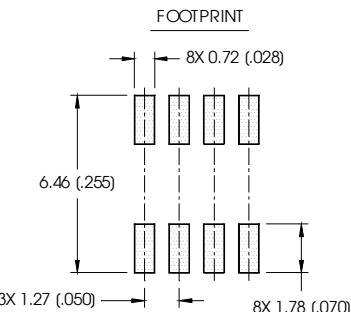
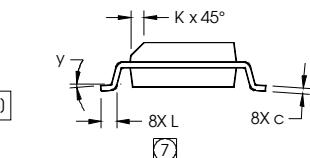
Fig 15c. Maximum Avalanche Energy Vs. Drain Current

SO-8 Package Outline (Mosfet & Fetky)

Dimensions are shown in millimeters (inches)



DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.0532	.0688	1.35	1.75
A1	.0040	.0098	0.10	0.25
b	.013	.020	0.33	0.51
c	.0075	.0098	0.19	0.25
D	.189	.1968	4.80	5.00
E	.1497	.1574	3.80	4.00
e	.050	BASIC	1.27	BASIC
e1	.025	BASIC	0.635	BASIC
H	.2284	.2440	5.80	6.20
K	.0099	.0196	0.25	0.50
L	.016	.050	0.40	1.27
y	0°	8°	0°	8°

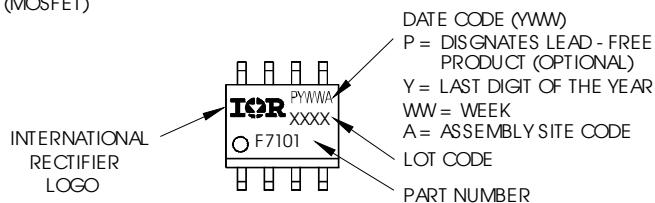


NOTES:

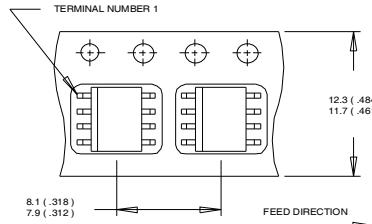
1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: MILLIMETER
3. DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.
- 5) DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.15 (.006).
- 6) DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.25 (.010).
- 7) DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE.

SO-8 Part Marking Information

EXAMPLE: THIS IS AN IRF7101 (MOSFET)

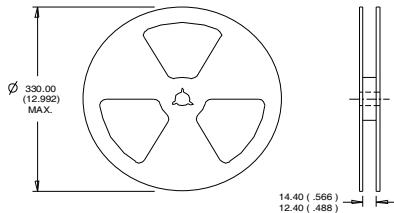


Note: For the most current drawing please refer to IR website at: <http://www.irf.com/package/>

SO-8 Tape and Reel (Dimensions are shown in millimeters (inches))

NOTES:

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES:

1. CONTROLLING DIMENSION : MILLIMETER.

2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Note: For the most current drawing please refer to IR website at: <http://www.irf.com/package/>

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting $T_J = 25^\circ\text{C}$, $L = 15\text{mH}$, $R_G = 25\Omega$, $I_{AS} = -1.4\text{A}$.
- ③ Pulse width $\leq 400\mu\text{s}$; duty cycle $\leq 2\%$.
- ④ When mounted on 1 inch square copper board.

Qualification information[†]

Qualification level	Industrial (per JEDEC JESD47F ^{††} guidelines)	
Moisture Sensitivity Level	SO-8	MSL1 (per JEDEC J-STD-020D ^{††})
RoHS compliant	Yes	

[†] Qualification standards can be found at International Rectifier's web site: <http://www.irf.com/product-info/reliability>

^{††} Applicable version of JEDEC standard at the time of product release

International
IR Rectifier

IR WORLD HEADQUARTERS: 101 N. Sepulveda Blvd., El Segundo, California 90245, USA
To contact International Rectifier, please visit <http://www.irf.com/photo-call/>